

Serial No. **5**
Not Yet Assigned

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

Applicant
Shubhendu S. MUKHERJEE

Filing Date
Concurrently Herewith

Group
Unknown

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

[illegible]

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

AA	AR-SMT: <i>Microarchitectural Approach To Fault Tolerance In Microprocessors</i> , Eric Rotenberg, (8 p.).
AB	DIVA: <i>A Dynamic Approach To Microprocessor Verification</i> , Todd M. Austin, Journal of Instruction-Level Parallelism 2 (2000) 1-6, Submitted 2/2000; published 5/2000 (26 p.).
AC	DIVA: <i>A Reliable Substrate For Deep Submicron Microarchitecture Design</i> , Todd M. Austin, May/June 1999 (12 p.).

EXAMINER

DATE CONSIDERED?

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP §609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

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Atty. Docket No.
1662-37000
(P00-3157)Serial No.
09/839,459Applicant
Shubhendu S. MUKHERJEEFiling Date
April 19, 2001Group
2183

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
h	AA	5,758,142	05/26/98	McFarling et al.	395	586	05/31/94
g	AB	5,933,860	08/03/99	Emer et al.	711	213	07/29/97

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	Translation YES NO

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

h	AC	M. Franklin, "Incorporating Fault Tolerance in Superscalar Processors," Proceedings of High Performance Computing, December, 1996.
h	AO	A. Mahmood et al., "Concurrent Error Detection Using Watchdog Processors - A Survey," IEEE Trans. on Computers, 37(2):160-174, February 1988.
h	AI	J. H. Patel et al., "Concurrent Error Detection In ALU's by Recomputing With Shifted Operands," IEEE Trans. on Computers, 31(7):589-595, July 1982.
h	AF	D. A. Reynolds et al., "Fault Detection Capabilities Of Alternating Logic," IEEE Trans. on Computers, 27(12):1093-1098, December 1978.
h	AI	E. Rotenberg et al., "Trace Cache: A Low Latency Approach To High Bandwidth Instruction Fetching," Proceedings of the 29th Annual International Symposium on Microarchitecture, pp. 24-34, December 1996.
h	AH	E. Rotenberg et al., "Trace Processors," 30th Annual International Symposium on Microarchitecture (MICRO-30), Dec. 1997.
h	AI	T. J. Slegel et al., "IBM's S/390 G5 Microprocessor Design," IEEE Micro, pp. 12-23, March/April 1999.
h	AJ	J. E. Smith et al., "Implementing Precise Interrupts In Pipelined Processors," IEEE Trans. on Computers, 37(5):562-573, May 1988.
h	AK	G. S. Sohi et al., "A Study Of Time-Redundant Fault Tolerance Techniques For High-Performance Pipelined Computers," Digest of Papers, 19th International Symposium on Fault-Tolerant Computing, pp. 436-443, 1989.
h	AL	G. S. Sohi et al., "Instruction Issue Logic For High-Performance, Interruptible, Multiple Functional Unit, Pipelined Computers," IEEE Transactions on Computers, 39(3):349-359, March 1990.
h	AM	D. M. Tullsen, et al., "Simultaneous Multithreading: Maximizing On-Chip Parallelism," Proceedings of the 22nd Annual International Symposium on Computer Architecture, Italy, June 1995.
h	AN	D. Tullsen et al., "Exploiting Choice: Instruction Fetch And Issue On An Implementable Simultaneous Multithreading Processor," Proceedings of the 23rd Annual International Symposium on Computer Architecture (ISCA), May, 1996.
h	AO	S. K. Reinhardt et al., "Transient Fault Detection Via Simultaneous Multithreading" (12 p.).
h	AP	L. Spainhower et al., "IBM S/390 Parallel Enterprise Server G5 Fault Tolerance: A Historical Perspective," IBM J. Res. Develop. Vol. 43, No. 5/6, September/November 1999, pp. 863-873.
h	AQ	M. Franklin, "A Study Of Time Redundant Fault Tolerance Techniques For Superscalar Processors" (5 p.).
h	AR	K. Sundaramoorthy et al., "Slipstream Processors: Improving Both Performance And Fault Tolerance" (6 p.).

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